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DATA SHEET
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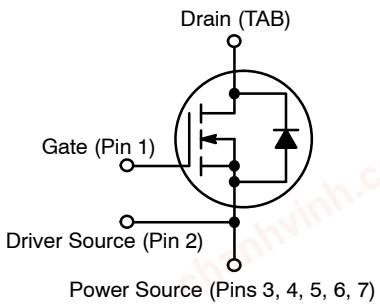
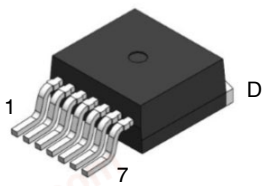
Silicon Carbide (SiC) MOSFET – EliteSiC, 44 mohm, 650 V, M2, D2PAK-7L

NTBG060N065SC1

$V_{(BR)DSS}$	$R_{DS(ON)}$ MAX	I_D MAX
650 V	70 mΩ @ 18 V	46 A



N−CHANNEL MOSFET



D2PAK−7L
CASE 418BJ

Features

- Typ. $R_{DS(on)}$ = 44 mΩ @ V_{GS} = 18 V
  Typ. $R_{DS(on)}$ = 60 mΩ @ V_{GS} = 15 V
- Ultra Low Gate Charge ($Q_{G(tot)}$ = 74 nC)
- Low Output Capacitance (C_{oss} = 133 pF)
- 100% Avalanche Tested
- T_J = 175°C
- RoHS Compliant

Typical Applications

- SMPS (Switching Mode Power Supplies)
- Solar Inverters
- UPS (Uninterruptable Power Supplies)
- Energy Storage

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain−to−Source Voltage			V_{DSS}	650	V
Gate−to−Source Voltage			V_{GS}	−8/+22	V
Recommended Operation Values of Gate − Source Voltage		T_C < 175°C	V_{GSop}	−5/+18	V
Continuous Drain Current (Note 2)	Steady State	T_C = 25°C	I_D	46	A
Power Dissipation (Note 2)	Steady State	T_C = 25°C	P_D	170	W
Continuous Drain Current (Notes 1, 2)	Steady State	T_C = 100°C	I_D	33	A
Power Dissipation (Notes 1, 2)	Steady State	T_C = 100°C	P_D	85	W
Pulsed Drain Current (Note 3)		T_C = 25°C	I_{DM}	130	A
Operating Junction and Storage Temperature Range			T_J, T_{stg}	−55 to +175	°C
Source Current (Body Diode)			I_S	46	A
Single Pulse Drain−to−Source Avalanche Energy (I_L = 10.1 A_{pk}, L = 1 mH) (Note 4)			E_{AS}	51	mJ
Maximum Lead Temperature for Soldering, 1/8″ from Case for 10 Seconds			T_L	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface mounted on a FR−4 board using1 in2 pad of 2 oz copper.
2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
3. Repetitive rating, limited by max junction temperature.
4. E_{AS} of 51 mJ is based on starting T_J = 25°C; L = 1 mH, I_{AS} = 10.1 A, V_{DD} = 50 V, V_{GS} = 18 V.

MARKING DIAGRAM



BG060N065SC1 = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping†
NTBG060N065SC1	D2PAK−7L	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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THERMAL CHARACTERISTICS

Parameter	Symbol	Typ	Max	Units
Thermal Resistance Junction−to−Case (Note 2)	$R_{\theta JC}$	0.88	−	°C/W
Thermal Resistance Junction−to−Ambient (Notes 1, 2)	$R_{\theta JA}$	−	40	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Typ	Max	Unit
OFF CHARACTERISTICS							
Drain−to−Source Breakdown Voltage	$V_{(BR)DSS}$	V_{GS} = 0 V, I_D = 1 mA		650			V
Drain−to−Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$	I_D = 20 mA, refer to 25°C			0.15		V/°C
Zero Gate Voltage Drain Current	I_{DSS}	V_{GS} = 0 V, V_{DS} = 650 V	T_J = 25°C			10	μA
			T_J = 175°C			1	mA
Gate−to−Source Leakage Current	I_{GSS}	V_{GS} = +18/−5 V, V_{DS} = 0 V				250	nA
ON CHARACTERISTICS							
Gate Threshold Voltage	$V_{GS(TH)}$	V_{GS} = V_{DS} , I_D = 6.5 mA		1.8	2.8	4.3	V
Recommended Gate Voltage	V_{GOP}			−5		+18	V
Drain−to−Source On Resistance	$R_{DS(on)}$	V_{GS} = 15 V, I_D = 20 A, T_J = 25°C			60		mΩ
		V_{GS} = 18 V, I_D = 20 A, T_J = 25°C			44	70	
		V_{GS} = 18 V, I_D = 20 A, T_J = 175°C			50		
Forward Transconductance	g_{FS}	V_{DS} = 10 V, I_D = 20 A			12		S
CHARGES, CAPACITANCES & GATE RESISTANCE							
Input Capacitance	C_{ISS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 325 V			1473		pF
Output Capacitance	C_{OSS}				133		
Reverse Transfer Capacitance	C_{RSS}				13		
Total Gate Charge	$Q_{G(TOT)}$	V_{GS} = −5/18 V, V_{DS} = 520 V, I_D = 20 A			74		nC
Gate−to−Source Charge	Q_{GS}				20		
Gate−to−Drain Charge	Q_{GD}				23		
Gate−Resistance	R_G	f = 1 MHz			3.9		Ω
SWITCHING CHARACTERISTICS							
Turn−On Delay Time	$t_{d(ON)}$	V_{GS} = −5/18 V, V_{DS} = 400 V, I_D = 20 A, R_G = 2.2 Ω, Inductive Load			11		ns
Rise Time	t_r				14		
Turn−Off Delay Time	$t_{d(OFF)}$				24		
Fall Time	t_f				11		
Turn−On Switching Loss	E_{ON}				45		μJ
Turn−Off Switching Loss	E_{OFF}				18		
Total Switching Loss	E_{TOT}				63		
SOURCE−DRAIN DIODE CHARACTERISTICS							
Continuous Source−Drain Diode Forward Current	I_{SD}	V_{GS} = −5 V, T_J = 25°C				46	A
Pulsed Source−Drain Diode Forward Current (Note 3)	I_{SDM}	V_{GS} = −5 V, T_J = 25°C				130	A
Forward Diode Voltage	V_{SD}	V_{GS} = −5 V, I_{SD} = 20 A, T_J = 25°C			4.3		V

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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SOURCE−DRAIN DIODE CHARACTERISTICS						
Reverse Recovery Time	t_{RR}	V_{GS} = −5/18 V, I_{SD} = 20 A, dI_S/dt = 1000 A/μs		17.7		ns
Reverse Recovery Charge	Q_{RR}			90.6		nC
Reverse Recovery Energy	E_{REC}			8.7		μJ
Peak Reverse Recovery Current	I_{RRM}			10.2		A
Charge time	Ta			9.8		ns
Discharge time	Tb			7.8		ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

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TYPICAL CHARACTERISTICS

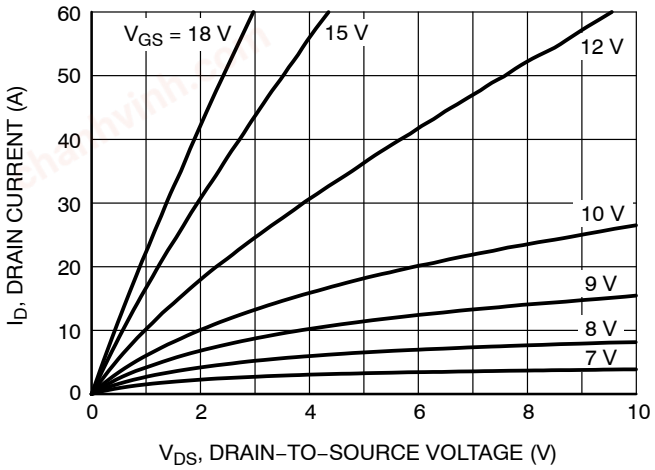

Figure 1. On−Region Characteristics

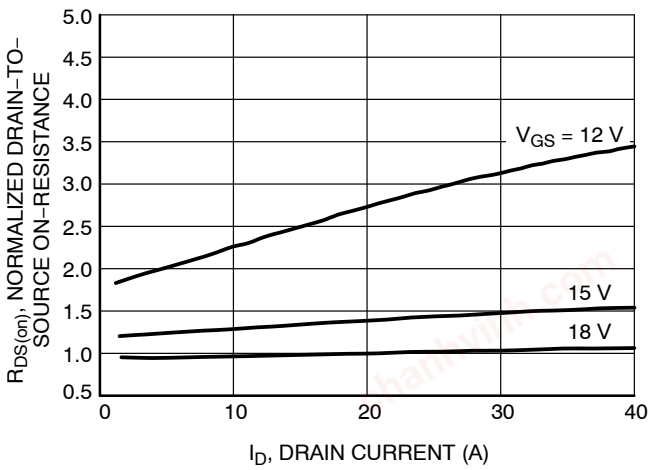

Figure 2. Normalized On−Resistance vs. Drain Current and Gate Voltage

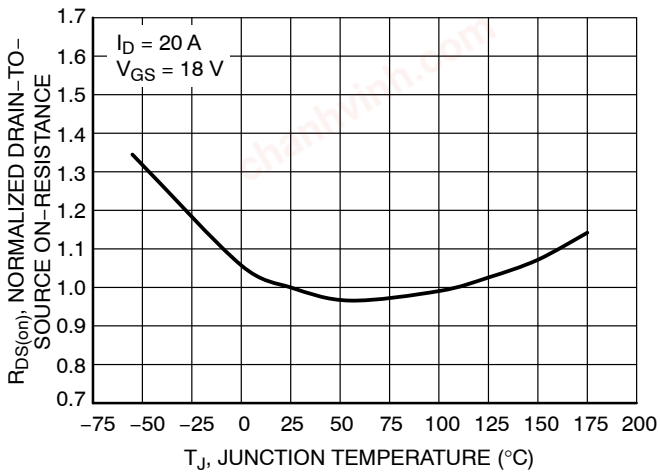

Figure 3. On−Resistance Variation with Temperature

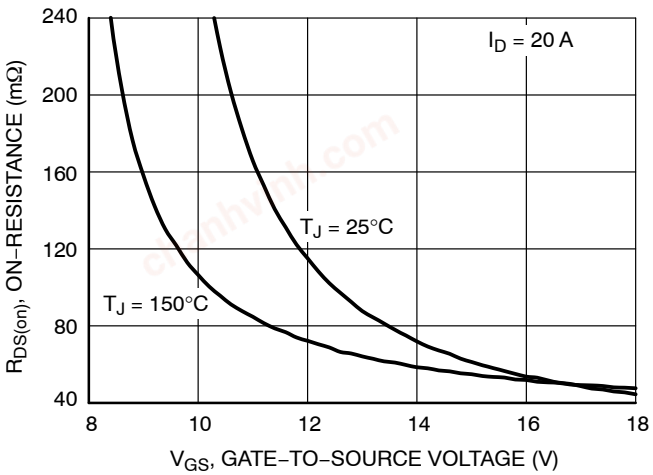

Figure 4. On−Resistance vs. Gate−to−Source Voltage

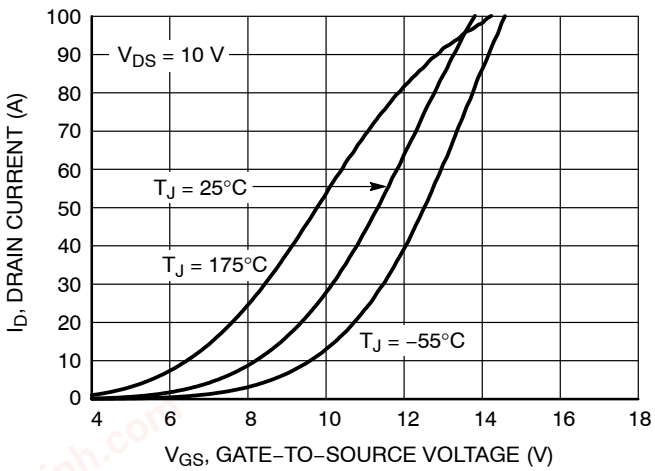

Figure 5. Transfer Characteristics

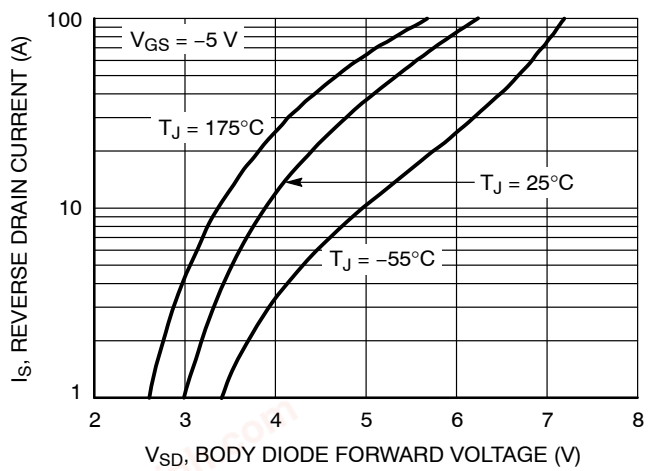

Figure 6. Diode Forward Voltage vs. Current

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TYPICAL CHARACTERISTICS

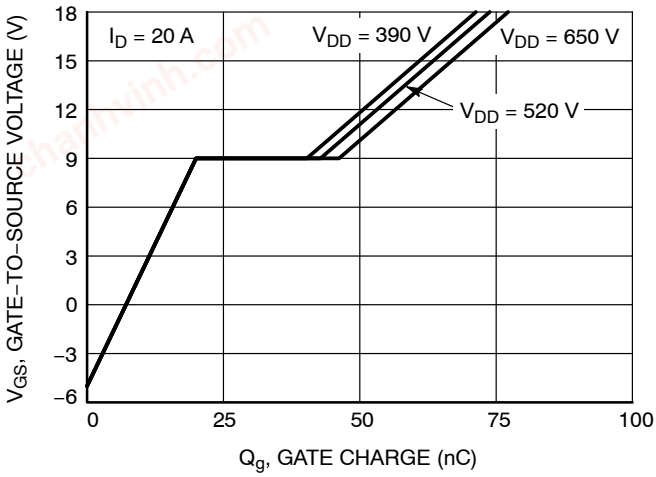

Figure 7. Gate−to−Source Voltage vs. Total Charge

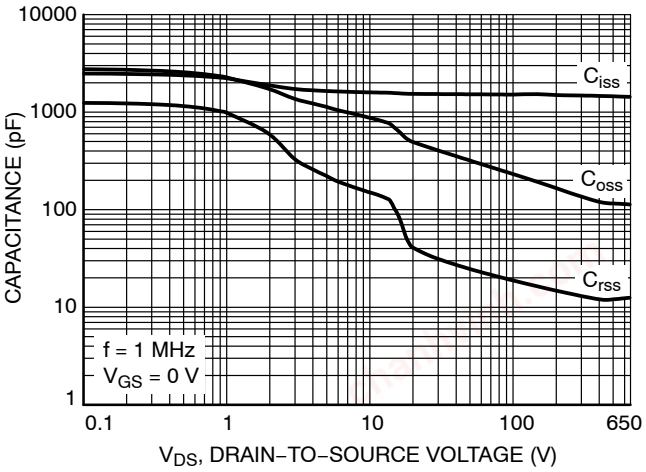

Figure 8. Capacitance vs. Drain−to−Source Voltage

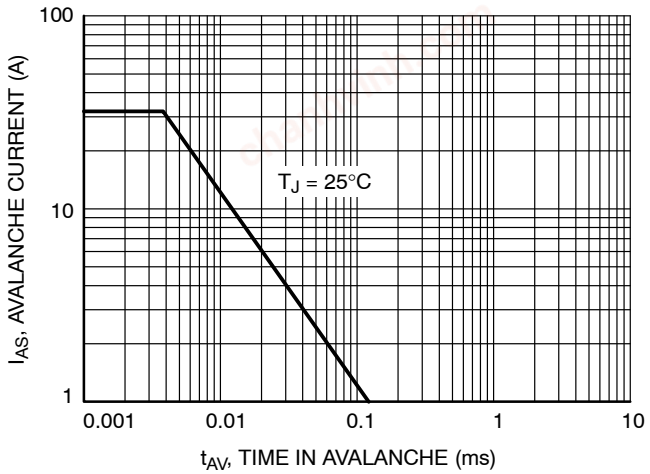

Figure 9. Unclamped Inductive Switching Capability

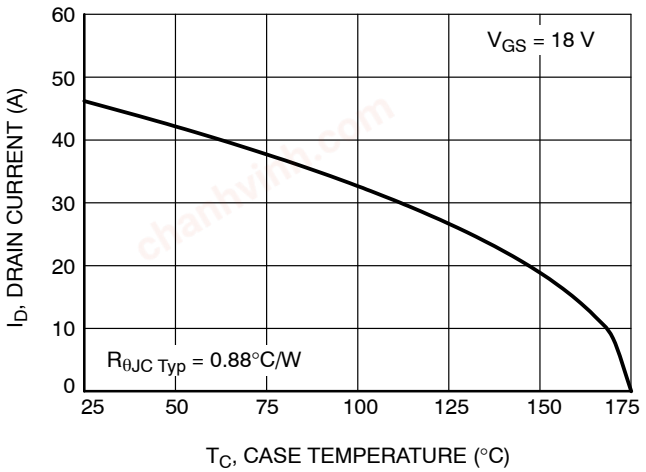

Figure 10. Maximum Continuous Drain Current vs. Case Temperature

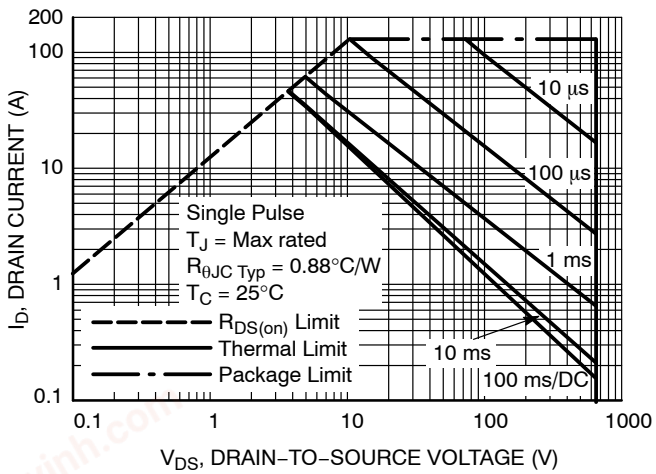

Figure 11. Safe Operating Area

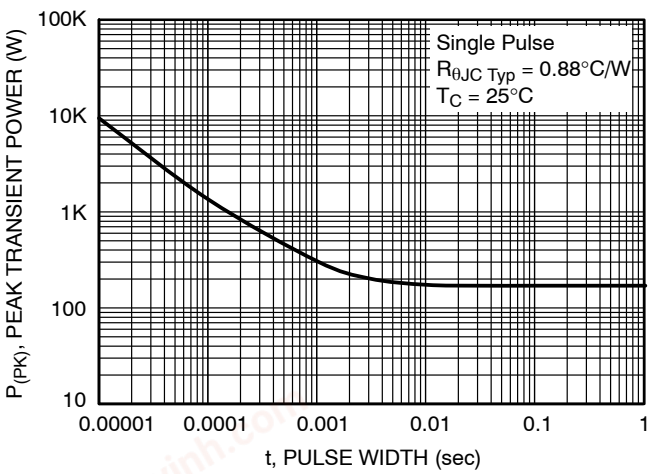

Figure 12. Single Pulse Maximum Power Dissipation

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TYPICAL CHARACTERISTICS

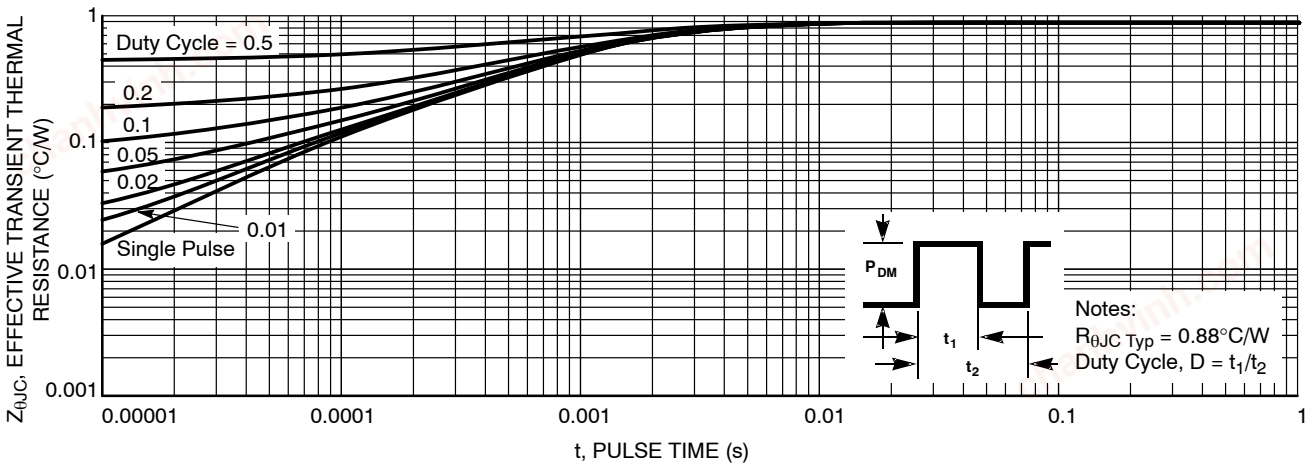

Figure 13. Junction−to−Case Transient Thermal Response

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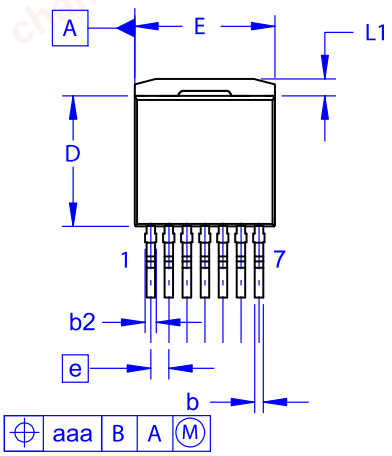
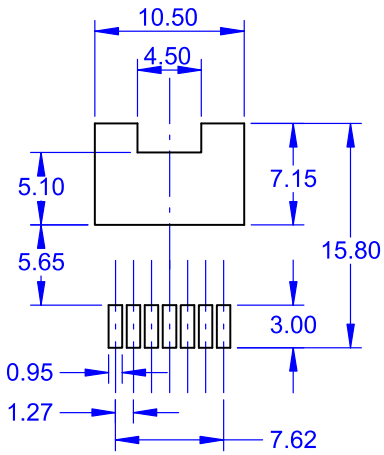
MECHANICAL CASE OUTLINE
PACKAGE DIMENSIONS

ON Semiconductor®

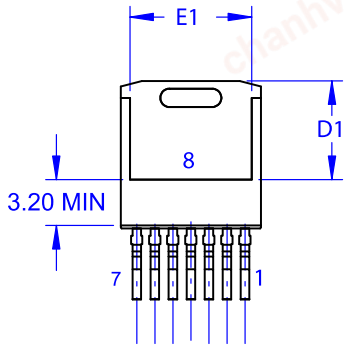
D²PAK7 (TO−263−7L HV)
CASE 418BJ
ISSUE B

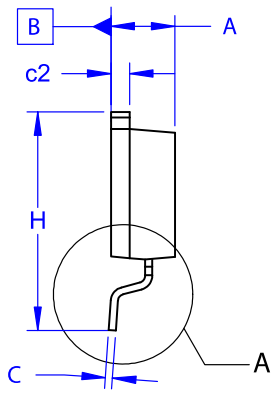
DATE 16 AUG 2019





LAND PATTERN RECOMMENDATION





NOTES:

A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED.
B. ALL DIMENSIONS ARE IN MILLIMETERS.
C. OUT OF JEDEC STANDARD VALUE.
D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.
E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

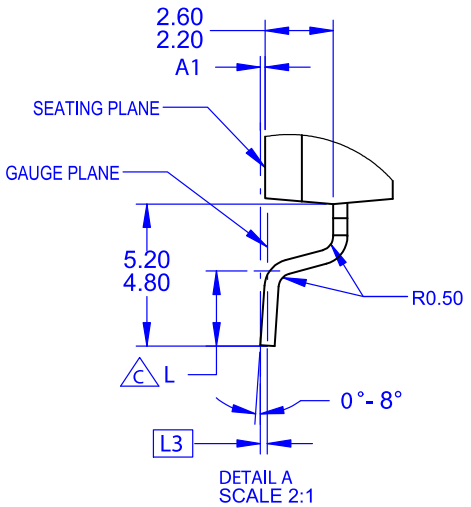
DIM	MILLIMETERS		
	MIN	NOM	MAX
A	4.30	4.50	4.70
A1	0.00	0.10	0.20
b2	0.60	0.70	0.80
b	0.51	0.60	0.70
c	0.40	0.50	0.60
c2	1.20	1.30	1.40
D	9.00	9.20	9.40
D1	6.15	6.80	7.15
E	9.70	9.90	10.20
E1	7.15	7.65	8.15
e	~	1.27	~
H	15.10	15.40	15.70
L	2.44	2.64	2.84
L1	1.00	1.20	1.40
L3	~	0.25	~
aaa	~	~	0.25

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
G = Pb−Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “▪”, may or may not be present. Some products may not follow the Generic Marking.



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DESCRIPTION:	**D²PAK7 (TO−263−7L HV)**	**PAGE 1 OF 1**

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